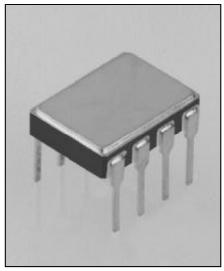


## **High Speed Optocouplers** Types HDC135, HDC136, HDC135B, HDC136B



### **Features**

- High speed
- TTL compatible
- High common mode transient immunity
- Wide bandwidth
- Open collector output

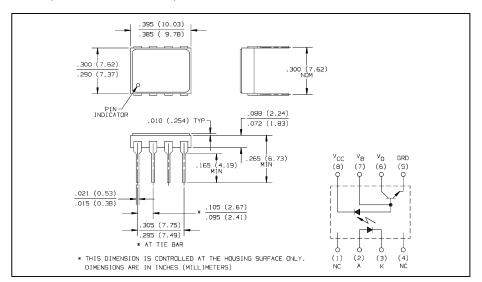
#### **Description**

Optek's HDC135 and HDC136 are high speed optocouplers, consisting of IR emitters and integrated photodetectors in hermetic side brazed dual-in-line 8 pin packages. Electrical characteristics are similar to the 6N135 and 6N136 optocouplers but with full military temperature range operation.

The HDC135B and HDC136B are high reliability optocouplers with 100% processing and Group Testing patterned after MIL-STD-883 Method 5004 and 5005 for class B.

Typical screening and lot acceptance tests are provided on page 13-4.

Minimum orders will apply to processed devices.



### **Absolute Maximum Ratings** (No derating required up to 70°C)

Storage Temperature Range
Operating Temperature Range55° C to +125° C
Lead Soldering Temperature [1/16 inch (1.6 mm) from case for 10 seconds) . 260° C
Average Input Current - I <sub>F</sub>
Peak Output Current - I <sub>F</sub> (50% duty cycle, 1 ms pulse width) 50 mA <sup>(2)</sup>
Peak Transient Input Current - I <sub>F</sub> (≤ 1 μs pulse width, 300 pps) 1.0 A
Reverse Input Voltage - V <sub>R</sub>
Input Power Dissipation
Average Output Current - IO 8.0 mA
Peak Output Current
Emitter-Base Reverse Voltage 5.0 V
Supply and Output Voltage - V <sub>CC</sub> , V <sub>O</sub> 0.5 V to 15 V
Base Current - I <sub>B</sub> 5.0 mA
Output Power Dissipation

Caution: This component is susceptible to damage from electrostatic discharge. Normal static prevention procedures should be used in handling. Notes:

- (1) Derate linearly above 70° C free-air temperature at a rate of 0.45 mA/° C. (2) Derate linearly above 70° C free-air temperature at a rate of 0.9 mA/° C.
- (3) Derate linearly above 70° C free-air temperature at a rate of 0.8 mW/° C.
- Derate linearly above 70° C free-air temperature at a rate of 1.8 mW/° C.
- (5) CM<sub>H</sub> is the maximum allowable dV/dt on the leading edge of a common mode pulse to assure that the output will not switch from high to low.
- CM<sub>L</sub> is the maximum negative dV/dt allowable on the trailing edge of a common mode pulse to assure that the output will not switch from low to high.
- Test conditions represents 1 TTL unit load with 5.6 k $\Omega$  pull-up resistor.
- (8) Test conditions represents 1 LSTTL unit load with a 6.1 k $\Omega$  pull-up resistor.
- (9) Device considered a two-terminal device: pins 2 and 3 shorted together and pins 5, 6, 7 and 8 shorted together.

# HI-REL OPTO

## **Types HDC135, HDC136, HDC135B, HDC136B**

**Electrical Characteristics** (Over recommended temperature  $T_A = -55^{\circ}$  C to  $+125^{\circ}$  C, unless otherwise noted)

SYMBOL	PARAMETER		MIN	TYP*	MAX	UNITS	TEST CONDITIONS	
CTR	Current Transfer Ratio	HDC135 HDC136	7.0 19.0	19.0 25.0		% %	$I_F = 16 \text{ mA}, V_O = 0.40 \text{ V},$ $V_{CC} = 4.5 \text{ V}, T_A = 25^{\circ} \text{ C}$	
		HDC135 HDC136	5.0 15.0	15.0 23.0		% %	$I_F = 16 \text{ mA}, V_O = 0.50 \text{ V},$ $V_{CC} = 4.5 \text{ V}$	
VoL	Logic Low Output Voltage	HDC135		0.100	0.40	V	$I_F = 16 \text{ mA}, I_O = 1.10 \text{ mA},$ $V_{CC} = 4.5 \text{ V}$	
		HDC136		0.100	0.40	V	$I_F = 16 \text{ mA}, I_O = 2.4 \text{ mA},$ $V_{CC} = 4.5 \text{ V}$	
Іон	Logic High Output Current			3.0	500	nA	$I_F = 0 \text{ mA}, V_O = V_{CC} = 5.5 \text{ V},$ $T_A = 25^{\circ} \text{ C}$	
				0.010	1.00	μΑ	$I_F = 0 \text{ mA}, V_O = V_{CC} = 15 \text{ V},$ $T_A = 25^{\circ} \text{ C}$	
					50	μΑ	$I_F = 0 \text{ mA}, V_O = V_{CC} = 15 \text{ V}$	
I <sub>CCL</sub>	Logic Low Supply Current			40		μΑ	$I_F = 16 \text{ mA}, V_O = \text{open},$ $V_{CC} = 15 \text{ V}$	
Іссн	Logic High Supply Current			0.020	1.00	μΑ	$I_F = 0 \text{ mA}, V_O = \text{open},$ $V_{CC} = 15 \text{ V}, T_A = 25^{\circ} \text{ C}$	
юсн					2.0	μΑ	$I_F = 0 \text{ mA}, V_O = \text{open},$ $V_{CC} = 15 \text{ V}$	
VF	Input Forward Voltage			1.50	1.70	V	$I_F = 16 \text{ mA}, T_A = 25^{\circ} \text{ C}$	
$\Delta V_F$ $\Delta T_A$	Temperature Coefficient of Forward Voltage			-1.80		mV/° C	I <sub>F</sub> = 16 mA	
BV <sub>R</sub>	Input Reverse Breakdown Voltage		5.0			V	I <sub>R</sub> = 10 μA, T <sub>A</sub> = 25° C	
Cin	Input Capacitance			42		pF	f = 1 MHz, V <sub>F</sub> = 0	
I <sub>IO</sub>	Input-Output Insulation Leakage Current				1.00	μА	45% Relative Humidity, t = 5 sec, V <sub>IO</sub> = 1000 Vdc, T <sub>A</sub> = 25° C (Note 9)	
Rio	Input-Output Resistance			10 <sup>12</sup>		Ω	V <sub>IO</sub> = 500 Vdc (Note 9)	
C <sub>IO</sub>	Input-Output Capacitance			0.50		pF	f = 1 MHz (Note 9)	
h <sub>FE</sub>	Transistor DC Current Gain			150		_	$V_O = 5 \text{ V}, I_O = 3 \text{ mA}$	
<b>Switching Specification</b> ( $T_A = 25^{\circ}$ C) $V_{CC} = 5.0$ V, $I_F = 16.0$ mA unless otherwise noted								
t <sub>PHL</sub>	Propagation Delay Time to Logic Low at Output	HDC135 HDC136		0.50 0.60	1.50 1.00	μs μs	$R_L = 4.1 \text{ k}\Omega \text{ (Note 8)}$ $R_L = 1.90 \text{ k}\Omega \text{ (Note 7)}$	
t <sub>PLH</sub>	Propagation Delay Time to Logic High at Output	HDC135 HDC136		0.40 0.80	1.50 1.00	μs μs	$R_L = 4.1 \text{ k}\Omega \text{ (Note 8)}$ $R_L = 1.90 \text{ k}\Omega \text{ (Note 7)}$	
СМн	Common Mode Transient Immunity at Logic High Level Output  HDC13			1000		V/µs	$I_F = 0$ mA, $V_{CM} = 10$ Vp-p, $R_L = 4.1$ k $\Omega$ (Notes 6,8)	
	2010/ Output	HDC136		1000		V/µs	I <sub>F</sub> = 0 mA, V <sub>CM</sub> = 10 Vp-p, R <sub>L</sub> = 1.90 kΩ (Notes 6,7)	
CML	Common Mode Transient Immunity at Logic Low Level Output	HDC135		-1000		V/μs	$V_{CM} = 10 \text{ Vp-p}, R_L = 4.1 \text{ k}\Omega,$ (Notes 5,8)	
	25.57 Output	HDC136		-1000		V/μs	$V_{CM} = 10 \text{ Vp-p}, R_L = 1.90 \text{ k}\Omega$ (Notes 5,7)	

All typicals at  $T_A = 25^{\circ}$  C and  $V_{CC} = 5$  V, unless otherwise noted